Report

Electronics

MINI USB CONN., RCPT, V/T, DIP, B TYPE

1. INTRODUCTION

1.1. Purpose

Testing was performed on the MINI USB CONN., RCPT, V/T, DIP, B TYPE connector to determine its conformance to the requirements of Product Specification 108-57509 Rev O.

1.2. Scope

This report covers the electrical, mechanical, and environmental performance of MINI USB CONN., RCPT, V/T, DIP, B TYPE manufactured by the Global Personal Computer Division.

1.3. Conclusion

MINI USB CONN., RCPT, V/T, DIP, B TYPE connector meets the electrical, mechanical, and environmental performance requirements of Product Specification 108-57509 Rev O.

1.4. Product Description

MINI USB CONN., RCPT, V/T, DIP, B TYPE connector is designed for printed circuit board applications. The contacts are copper alloy, gold plated on the contact interface and Tin-Cu plating on the solder tail, all over nickel under-plated. The housing material is glass filled insulating polymer, UL94V-0.

1.5. Test Samples

The test samples were randomly selected from normal current production lots, and the following part numbers were used for test:

Test Group	Quantity	Description			
A, B, C, D, E	5 ea.	MINI USB CONN., RCPT, V/T, DIP, B TYPE			

DR	DATE	APVD	DATE
Oblic Hu	26-Nov-2004	Wei-Jer Ke	26-Nov-2004
			FZ00-0218-04



This specification is a controlled document.

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1.6. Qualification Test Sequence

	Test Group						
Test or Examination	Α	В	С	D	Е		
	Test Sequence (a)						
Examination of product	1,11	1,5	1,7	1,4	1,3		
Low Level Contact Resistance	3,8	2,4					
Insulation Resistance			3				
Dielectric Withstanding Voltage			4				
Contact Capacitance			2				
Contact Current Rating				2			
Random Vibration	6						
Physical Shock	7						
Durability	5						
Connector Mating Force	2,10						
Connector Unmating Force	4,9						
Thermal Shock			5				
Humidity			6				
Temperature Life (see note c)		3					
Solderability				3	·		
Resistance to Soldering Heat					2		

Figure 1.

NOTE: (a) The numbers indicate sequence in which tests were performed.

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2. TEST RESULT

GP	TEST	ODEO	DATA			
	TEST	SPEC.	Max.	Min.	Mean	σ
	Contact Mating force	3.57Kgf Max.	2.44	2.04	2.23	0.4
	Low Level Contact Resistance	50 MΩ Max	15.24	11.12	13.63	4.12
	Contact Unmating force	0.71Kgf Min	1.88	1.63	1.75	0.25
	Durability	5000 Cycles	OK	ок	ок	OK
٨	Random Vibration	5.35 G,	OK	ОК	ОК	OK
A	Physical Shock	30G, 11mSec	OK	ок	ок	ОК
	Low Level Contact Resistance	50mΩMax.	16.47	12.25	14.47	4.22
	Contact Unmating force	0.31Kgf Min	1.34	0.88	1.15	0.56
	Contact Mating force	3.57Kgf Max.	1.81	1.61	1.71	0.2
	Appearance	No Damage.	ОК		ОК	ОК
	Low Level Contact Resistance	50m Ω Max.	16.22	12.20	14.53	4.02
В	Temperature Life	85℃±5℃ 250 h	OK	ок	ок	ОК
	Low Level Contact Resistance	50m Ω Max.	16.55	13.07	4.98	3.48
	Appearance	No Damage.	ок		ок	ОК
С	Contact Capacitance	2pF Max	OK	ок	ок	ок
	Insulation Resistance	100 MΩMin	OK	ОК	ок	OK
	Dielectric Withstanding Voltage	1000V AC	OK	ОК	ок	OK
	Thermal Shock	–55℃ to +85℃ 5 Cycle	OK	ок	ок	ОК
	Humidity	40℃, 90-95%RH 168h.	OK	ОК	OK	OK
	Appearance	No Damage.	ОК		ОК	ОК
-	Contact Current Rating	250V AC 1 Minute	ОК	ок	ОК	ОК
	Solderability	95% solder coverage.	OK	ОК	OK	ОК
	Appearance	No Damage.	ОК		ок	ОК
ΙE	Resistance to Wave Soldering Heat	265±5℃ for 10±0.5sec.	OK	ок	ОК	OK
	Appearance	No Damage.	ок		ок	ОК

Figure 2.

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